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Fabrication of TiAl_3 coating on TiAl-based alloy by Al electrodeposition from dimethylsulfone bath and subsequent annealing

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Abstract

TiAl_3 coating was formed on TiAl alloy by Al electrodeposition from a dimethylsulfone (DMSO_2) bath and subsequent annealing. Before the Al electrodeposition, anodic dissolution of TiAl substrate in the DMSO_2 bath was conducted to remove the surface oxide layer of the TiAl substrate. By performing the Al electrodeposition immediately after the anodic dissolution, uniform Al films adherent to the TiAl substrate could be obtained. Annealing at 650-1000 °C yielded a single TiAl_3 layer or two layers of TiAl_3 and TiAl_2 on the TiAl substrate. The resulted TiAl_3 layer was confirmed to show oxidation-resistance at high temperatures.

Keywords

Electroplating, Organic solvent, Aluminide, Intermetallics, Diffusion

1. Introduction

TiAl-based alloys have great potential for high-temperature structural applications such as turbine blades of internal-combustion engines, owing to their high specific strength and high creep resistance at elevated temperatures [1-3]. However, the TiAl alloys suffer heavy oxidation at high temperatures over 700 °C, because they do not form the long-lasting protective Al_2O_3 scale, but rather a nonprotective $\text{TiO}_2 + \text{Al}_2\text{O}_3$ mixed scale [4-6]. Thus, a surface finishing is required to improve the oxidation resistance without altering the bulk properties. Unlike TiAl or Ti_3Al , the Al-rich intermetallic, TiAl_3 , is capable of forming the protective Al_2O_3 scale, and therefore TiAl_3 is often employed as an oxidation-resistant coating. Various processes to form the TiAl_3 coating on the TiAl based alloys have been studied, including pack cementation [6-8], hot-dip coating [9-11], arc melting [12], electro-spark deposition [13], sputtering [14-16], and thermal spray coating [17]. In this paper, we propose a process composed of Al electrodeposition on the TiAl alloys and subsequent annealing for the formation of TiAl_3 layer through interdiffusion. This approach using electrodeposition has advantages over the aforementioned processes in that the thickness of the coating can be controlled easily, the coating can be formed even on surfaces with complex shapes, and the process cost is low.

Electrodeposition of Al does not occur in an aqueous solution, and thus requires a non-aqueous medium as an electrolytic bath. We used a dimethylsulfone (DMSO_2)- AlCl_3 bath [18]. The merits of this electrolyte are that uniform Al films can be electrodeposited at high rates at around room temperature [19], problematic vaporization of AlCl_3 is suppressed because DMSO_2 coordinates to Al ions and stabilizes them, and furthermore this electrolyte is much less expensive than the room temperature molten salts studied for Al electrodeposition [20, 21].

In this work, we studied the formation of TiAl_3 coating on a TiAl substrate by electrodeposition of Al from the DMSO_2 bath and subsequent annealing to demonstrate the feasibility of this process. In general, electrodeposited films do not adhere well to Ti-Al alloys because Ti-Al alloys have a natural oxide layer on their surfaces [22]. To remove the oxide layer and to obtain an Al layer adhering to the TiAl substrate, anodic dissolution of the TiAl substrate was conducted in the DMSO_2 bath prior to the Al electrodeposition. By performing the Al electrodeposition immediately after

the anodic dissolution, the Al layer can be electrodeposited on the bare surface of the TiAl substrate, securing sufficient adhesion to the substrate. After the Al electrodeposition, annealing to form the TiAl₃ layer was conducted in the temperature range from 650 °C to 1000 °C.

2. Experimental procedures

2.1 Materials

The TiAl alloy substrate was prepared from a Ti-47 at.% Al ingot which has a lamellar structure composed of γ -TiAl and α_2 -Ti₃Al phases. The ingot was sliced into plates with a thickness of about 0.6 mm. The surface of the alloy plate was polished with SiC papers, and the plate was immersed in 10% oxalic acid at 80 °C for 60 min. After rinsing in distilled water and drying, a part of the TiAl plate was covered with PTFE tape so that only a certain area (10 mm squared) would be exposed. The TiAl plate had been dried at 60 °C for 24 h under a reduced pressure prior to use.

The electrolyte for Al electrodeposition was prepared in an Ar-filled glove box equipped with a circulation system. DMSO₂ (Tokyo Chemical Industry, 99%) and AlCl₃ (Fluka, anhydrous, 99%) were used as the solvent and Al source, respectively. Dimethylamine hydrochloride ((CH₃)₂NH₂Cl, Sigma-Aldrich, 99%) was added to the electrolyte to inhibit the inclusion of impurities such as sulfur and chlorine to the electrodeposited Al layer. The DMSO₂ and the dimethylamine hydrochloride were used after drying for 24 h at 60 °C and 120 °C, respectively. AlCl₃ had been stored in the glove box and was used as received. The mol ratio of DMSO₂ to AlCl₃ to dimethylamine hydrochloride of the electrolytic bath was 10 : 2 : 0.1.

2.2 Anodic Dissolution and Electrodeposition

The anodic dissolution of the TiAl substrate and the electrodeposition of Al layer were performed in the Ar-filled glove box. A glass vessel with a volume of 150 mL was used as an electrochemical cell. The TiAl plate described above and an Al plate (Nilaco, 99%) were used as the working and counter electrodes, respectively. As a reference electrode, an Al wire immersed in a mixture of DMSO₂ and AlCl₃ with a ratio of 10 : 2 was employed. The anodic dissolution and the electrodeposition were carried out with an electrochemical analyzer (ALS, model 660 C). The temperature of the electrolyte was maintained at 110 °C by a thermostat. The electrolyte

was stirred by a magnetic stirrer at 80 rpm during the electrochemical reactions. The anodic polarization curve was measured at the scan rate of 10 mV s⁻¹.

2.3 Annealing

The TiAl substrate covered with the electrodeposited Al layer was annealed in a vacuum (<0.4 Pa) pulled by a diffusion pump. The annealing temperatures were varied in the range from 650 to 1000 °C. The samples were first heated to the annealing temperatures from ambient temperature in an hour, and then kept at the annealing temperatures for an hour. Finally, they were slowly cooled in the furnace.

2.4 Characterization

Samples were investigated by X-ray diffraction (XRD, PANalytical, X'Pert PRO-MPD) and scanning electron microscope (SEM, Hitachi S-3500) equipped with an energy dispersive X-ray spectrometer (EDX). XRD was measured from the surface of the sample. For cross-sectional observation by SEM, samples were cut and polished with diamond paste (1 μm) followed by ultrasonic cleaning.

3. Results and discussion

3.1 Anodic dissolution of TiAl substrate as pretreatment

Al layers electrodeposited on the TiAl substrate without pretreatment did not show sufficient adhesion to the substrate and easily delaminated. The poor adhesion would be due to the natural oxide layer on the TiAl substrate. Cleaning of the substrate in 10% oxalic acid was not effective; although the oxide layer can be dissolved away in the acid, surface oxidation of the TiAl substrate occurs again as soon as the substrate contacts air. In order to remove the oxide layer completely and to make it possible to deposit Al layer onto the bare TiAl surface, the TiAl substrate was anodically dissolved in the DMSO₂ bath.

The anodic polarization curve for the TiAl substrate in the DMSO₂ bath (Fig. 1) was first taken to elucidate the dissolution behavior. When the potential of the substrate was scanned from the open circuit potential (0.47 V) to the anodic direction, anodic current was observed at above 0.5 V. Since the anodic decomposition of the DMSO₂ bath does not occur until 2.5 V [23],

this anodic current must be due to the dissolution of the TiAl substrate. No sign of passivation was observed in this measurement range, unlike the case of the $\text{AlCl}_3\text{-NaCl-KCl}$ bath where TiAl is passivated by the formation of TiCl_3 layer [24]. This indicates that the solubility of TiCl_3 is higher in the DMSO_2 bath than in the $\text{AlCl}_3\text{-NaCl-KCl}$ system.

Figure 2 shows the morphology of the surface of the TiAl substrate after the anodic dissolution at 0.8, 1.4 and 2.0 V for 30 C cm^{-2} . The SEM observation confirmed that the dissolution occurred all over the surface of the substrate at all the potentials, but the morphologies resulting from the dissolution differed with potential. The dissolution at 0.8 and 1.4 V generated a rough stripe pattern corresponding to the lamellar structure of the TiAl substrate (Figs. 2a and b). EDX analysis revealed that the Al content of the part where the dissolution proceeded more was 49 at.%, while that of the less dissolved part was 31 at.%, indicating that the TiAl phase dissolved faster than Ti_3Al from the lamellar structure (inset in Fig. 2a). In contrast, the dissolution at 2.0 V (Fig. 2c) produced a morphology unrelated to the lamellar structure, implying that the dissolution rates of the TiAl and Ti_3Al phases were almost the same at this potential. The reason for the evolution of the characteristic morphology is not clear. However, active dissolution of the TiAl substrate surely occurs at the potentials over 0.8 V and thus the bare surface of the TiAl substrate without the oxide layer can be exposed to the electrolyte.

Figure 3 shows the variation of the dissolution current of the TiAl substrate with time at 2 V. The dissolution current increased steeply at the beginning of the polarization and became 40 mA cm^{-2} in 10 sec. The current then increased gradually and reached a constant value of 50 mA cm^{-2} after about 150 sec. The initial low current implies that the surface oxide layer prevents the active dissolution of the TiAl substrate. Because the oxide layer disappears as the dissolution proceeds, the dissolution current increases with time. Thus, the oxide layer seems to have been completely removed when the current density reached the constant value in 150 sec. The amount of electrical charge used for the anodic dissolution until 150 sec was about 6.7 C cm^{-2} . Anodic dissolution as a pretreatment for the TiAl substrate was carried out thereafter at 2 V for 10 C cm^{-2} , ensuring complete removal of the surface oxide layer. It should be noted that the polarization curve of Fig. 1 was also taken after this anodic dissolution was performed to remove the

surface oxide layer. If the substrate was covered with oxide, a smaller current would be observed.

3.2 Electrodeposition of Al layer

An Al layer firmly adhering to the TiAl substrate could be obtained by performing galvanostatic electrodeposition at 120 mA cm^{-2} for 1000 sec after the anodic dissolution of the TiAl substrate. XRD analysis confirmed that the electrodeposited layer was composed of metallic Al (Fig. 4). Figure 5 shows a cross-sectional SEM image of the electrodeposited sample together with composition profile measured by EDX, indicating the formation of a dense, uniform Al layer with a thickness of about $40 \text{ }\mu\text{m}$. The current efficiency for the Al electrodeposition can be estimated to be almost 100% from the thickness of the Al layer. The SEM image also reveals the rough interface and a small crack between the Al layer and the TiAl substrate. The presence of the crack, which seems to have been caused during the sample preparation for the cross-sectional observation, suggests that the adhesion of the Al layer to the substrate is still not very high. However, the adhesion is strong enough to prevent the Al layer from delamination. The rough surface of the substrate should have been caused by the anodic dissolution. Such a rough surface strengthens the adhesion of the electrodeposited layer by the anchor effect. Anodic dissolution therefore seems to contribute to the enhancement of the adhesion in two ways: removal of the oxide layer and roughening the surface of the substrate. Chu and Wu reported that sputtered Al films on TiAl substrate spalled out from the substrate when the thickness of the Al film was over $5 \text{ }\mu\text{m}$ [16]. In contrast, dense Al films with a thickness of more than $40 \text{ }\mu\text{m}$ could be obtained by electrodeposition.

3.3 Formation of TiAl_3 layer by annealing

The TiAl substrate with the electrodeposited Al layer was annealed at 650, 700 and $1000 \text{ }^\circ\text{C}$ to form a TiAl_3 layer through interdiffusion. Figure 6 shows XRD patterns of the samples after the annealing. In the pattern of the sample annealed at $650 \text{ }^\circ\text{C}$, which is lower than the melting point of Al ($660 \text{ }^\circ\text{C}$), diffractions of Al and TiAl_3 were detected. The surface of this sample kept its silver-white appearance even after the annealing, indicating that a part of the electrodeposited Al remained at the surface without diffusing to form intermetallic compounds. In contrast, the surface of the

samples turned to silver-gray by the annealing at higher temperatures (700 °C and 1000 °C). The XRD patterns of these samples showed only the diffraction peaks of TiAl_3 , indicating absence of the unreacted Al layer.

Figure 7 shows SEM images and composition profiles of the cross-sections of the annealed samples. Although the sample annealed at 650 °C had an unreacted Al layer on the surface, this fell off when the sample was cut for the cross-sectional observation. The unreacted Al layer therefore cannot be seen in the SEM image (Fig. 7a). The SEM image, however, confirmed the formation of an intermetallic compound layer. The composition of the layer was determined by EDX to be 75 at.% Al and 25 at.% Ti, indicating that the produced compound was TiAl_3 . This is in agreement with the XRD analysis (Fig. 6a). The annealing at the temperature lower than the melting point of Al could generate the TiAl_3 layer by solid-state diffusion, but the one-hour annealing at this temperature was too short for the 40- μm -thick Al layer to fully react with the TiAl substrate. In contrast, the whole Al layer diffused to form intermetallic compounds at the higher temperatures. The cross-section of the sample annealed at 700 °C showed the formation of a single phase of TiAl_3 on the TiAl substrate (Fig. 7b). The annealing at 1000 °C yielded an additional compound layer between the surface TiAl_3 layer and the TiAl substrate (Fig. 7c). Judging from the composition, the additional layer should be TiAl_2 phase. Because the TiAl_2 phase existed behind the TiAl_3 layer with the thickness of 30 μm , it is reasonable that the XRD patterns taken from the surface of the sample did not detect the TiAl_2 phase. In the TiAl_3 layer, formation of some voids was observed. These voids could be caused by flux imbalance between the slowly diffusing Ti and rapidly diffusing Al [25]. The void formation was less pronounced in the sample annealed at the lower temperatures.

3.4 Oxidation test

The TiAl substrate, a part of which was coated with the TiAl_3 layer through the process with the annealing at 700 °C, was heated in air at 1100 °C for an hour to verify the oxidation-resistance of the TiAl_3 coating. By the heating in air, the uncoated area of the TiAl substrate turned to white, while the coated area did not change its silver-gray appearance. The cross-sectional SEM image of the uncoated part revealed that a thick oxidation layer (about 60 μm) grew on the TiAl substrate (Fig. 8). EDX

analysis of the points marked in Fig. 8 suggested that the oxide layer consisted of an outer TiO_2 layer, and an Al_2O_3 and TiO_2 mixed-oxide layer (Table 1), as has frequently been described in the literature (see, e.g. Ref [6]). In contrast, the cross sectional SEM image and composition profile of the part with the TiAl_3 coating showed that the TiAl_3 phase was still present as the dominant phase, although an additional phase of TiAl_2 emerged by the progress of the diffusion at 1100 °C (Fig. 9). The composition profile also revealed an enrichment of Al at the surface of the TiAl_3 layer. The Al enrichment is attributed to the generation of Al_2O_3 by preferential oxidation of the TiAl_3 layer [6]. The Al enrichment was only observed at the vicinity of the surface, and thus this surface Al_2O_3 layer seems to have suppressed the progress of the oxidation. This result is consistent with the reports on TiAl_3 coatings fabricated by other techniques [6, 11, 13, 16], confirming that the coating formed by the electrodeposition and annealing shows high oxidation resistance at high temperatures.

4. Conclusions

The TiAl_3 oxidation-resistant coating was formed on the TiAl substrate by electrodeposition of Al from the DMSO_2 bath and subsequent annealing. By performing the anodic dissolution of the TiAl substrate in the DMSO_2 bath, the surface oxide layer of the TiAl substrate could be removed, and thereby the Al layer could be electrodeposited on the bare surface of TiAl substrate. As a result, a dense, uniform Al layer with good adhesion to the substrate could be obtained. Annealing of the TiAl substrate with the electrodeposited Al layer at 650, 700 and 1000 °C in vacuum generated the TiAl_3 layer. However, a part of the Al layer remained unreacted after one-hour annealing at 650 °C. The annealing at 700 °C yielded a single layer of TiAl_3 , while a multilayer of $\text{TiAl}_3/\text{TiAl}_2$ emerged by the annealing at 1000 °C. The TiAl_3 layer formed through the above process was demonstrated to work as an oxidation-resistant coating at high temperatures.

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Table 1 Composition of the surface oxidation layer of TiAl substrate generated by heating at 1100 °C in air.

Position ^a	Content (at. %)		
	Ti	Al	O ^b
A	20.3	3.1	76.6
B	12.6	21.8	65.6
C	11.2	27.7	61.1

a: The analyzed positions are indicated in Fig. 8.

b: The reliability of the O contents determined by EDX is low.

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Fig. 1: Anodic polarization curve for TiAl substrate in DMSO₂ bath.

Fig. 2: SEM images of the surface of the TiAl substrate after anodic dissolution at (a) 0.8 V, (b) 1.4 V and (c) 2.0 V for 30 C cm⁻² in DMSO₂ bath. The Al contents of points A and B marked in the inset of (a) were determined to be 31 and 49 at.% by EDX, respectively.

Fig. 3: Variation of dissolution current of TiAl substrate with time in DMSO₂ bath.

Fig. 4: XRD pattern of electrodeposited Al layer on TiAl substrate.

Fig. 5: SEM image and composition profile of cross-section of electrodeposited Al layer on TiAl substrate.

Fig. 6: XRD patterns of samples annealed at (a) 650 °C, (b) 700 °C and (c) 1000 °C.

Fig. 7: SEM images and composition profiles of cross-sections of the samples annealed at (a) 650 °C, (b) 700 °C and (c) 1000 °C.

Fig. 8: Cross-sectional SEM image of TiAl substrate without TiAl₃ coating after oxidation in air at 1100 °C.

Fig. 9: SEM images and composition profiles of cross section of TiAl substrate coated with TiAl₃ after oxidation in air at 1100 °C.

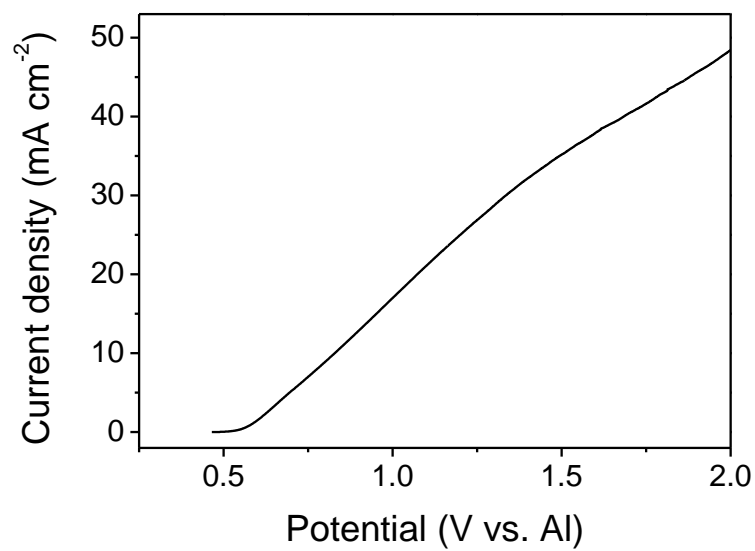


Fig. 1

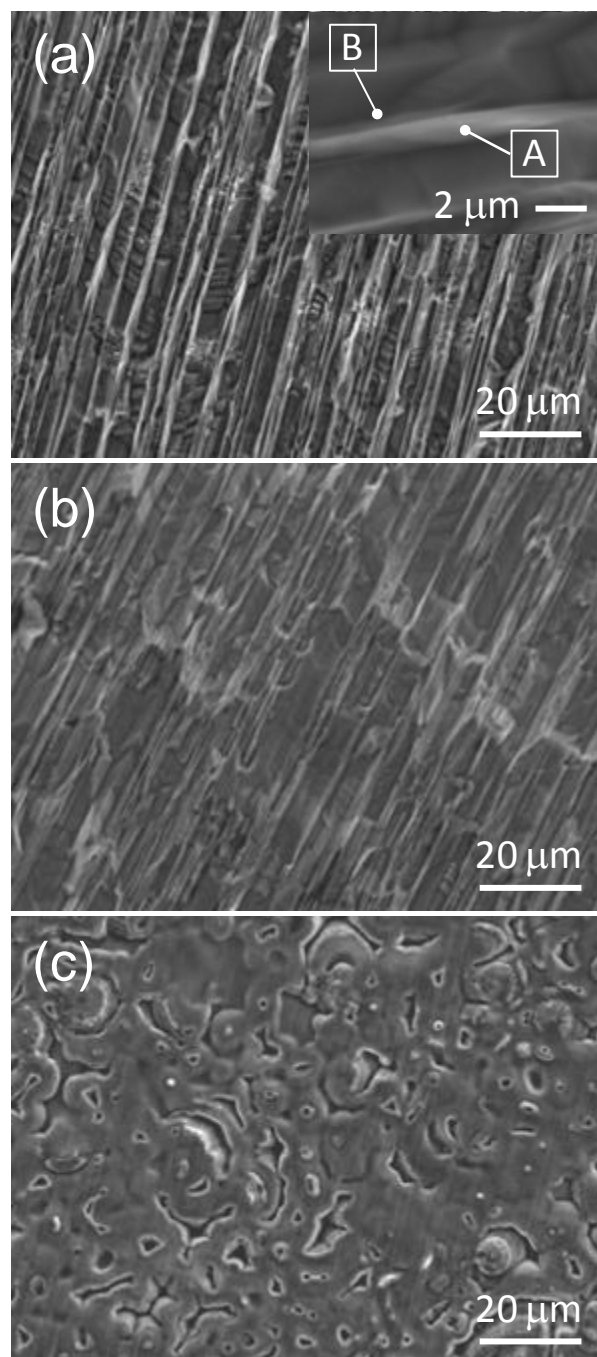


Fig. 2

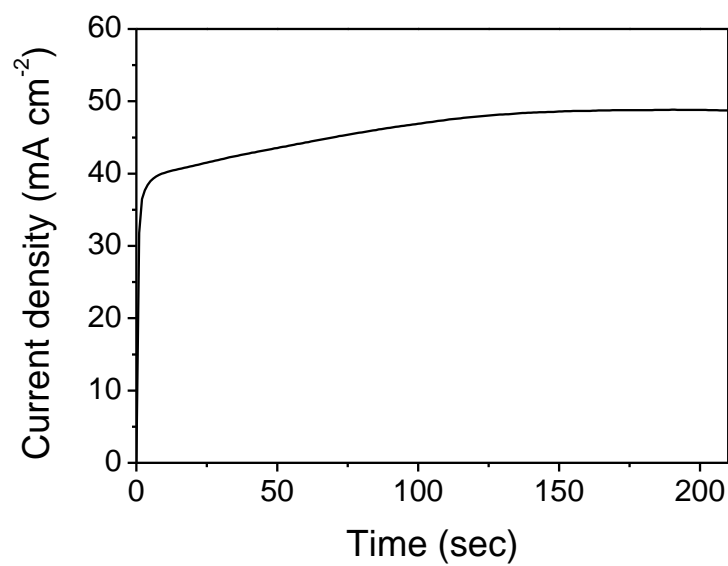


Fig. 3

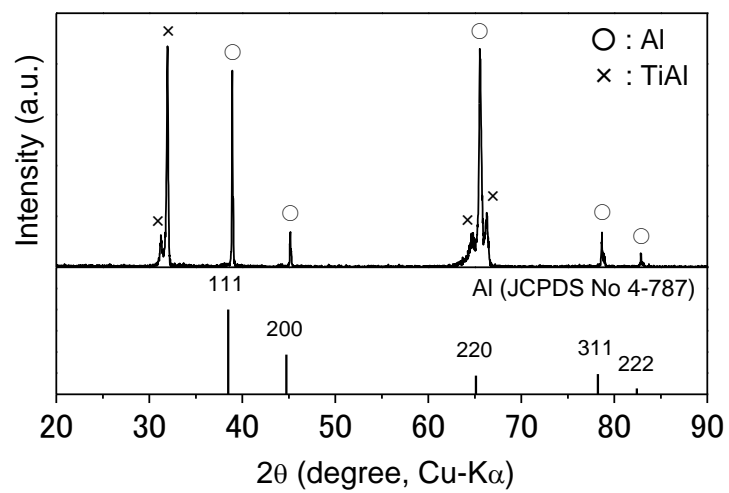


Fig. 4

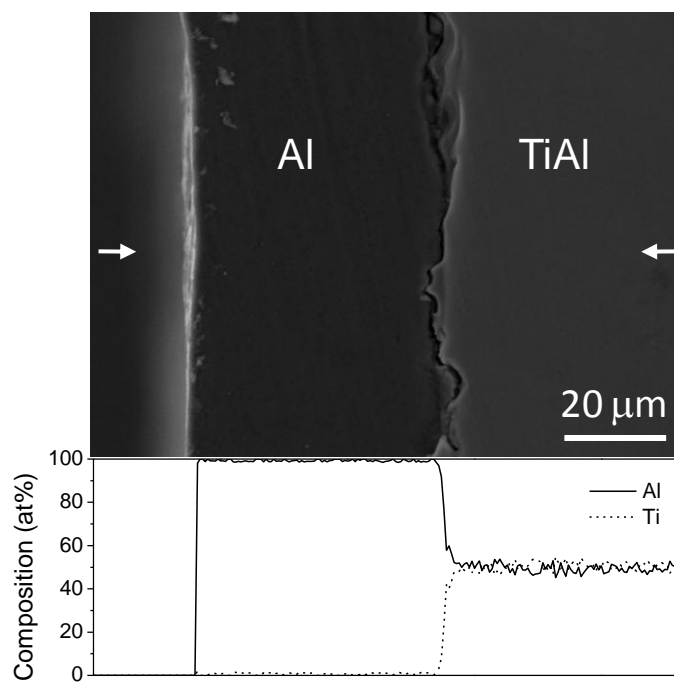


Fig. 5

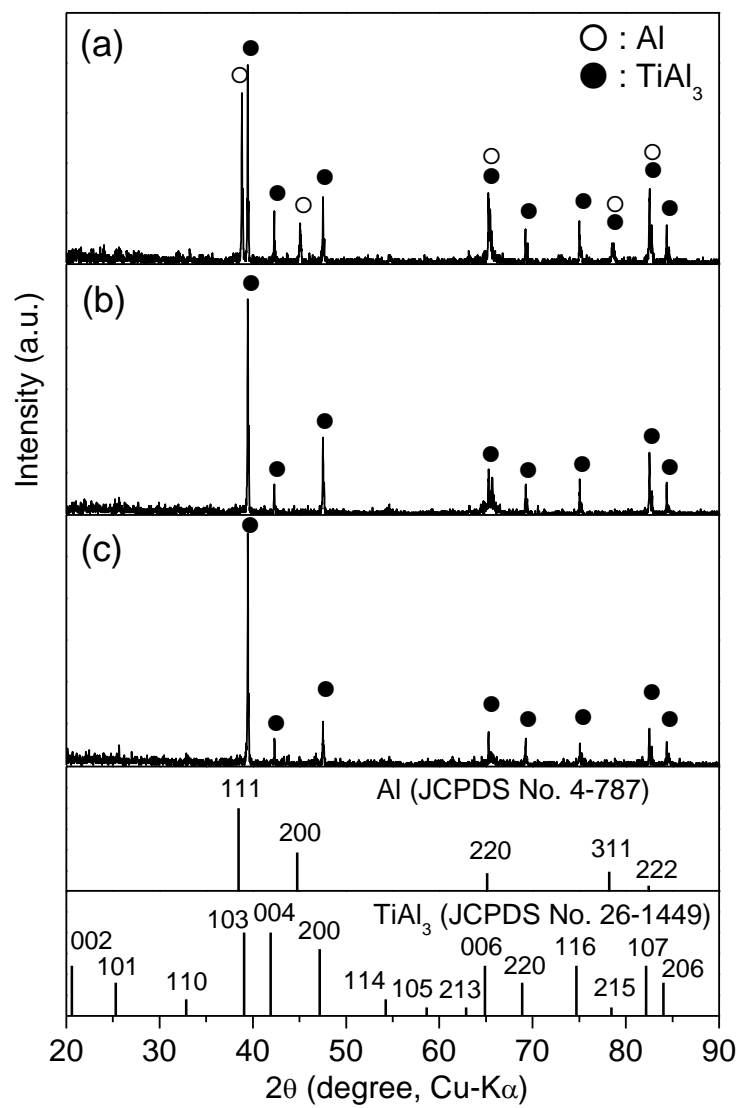


Fig. 6

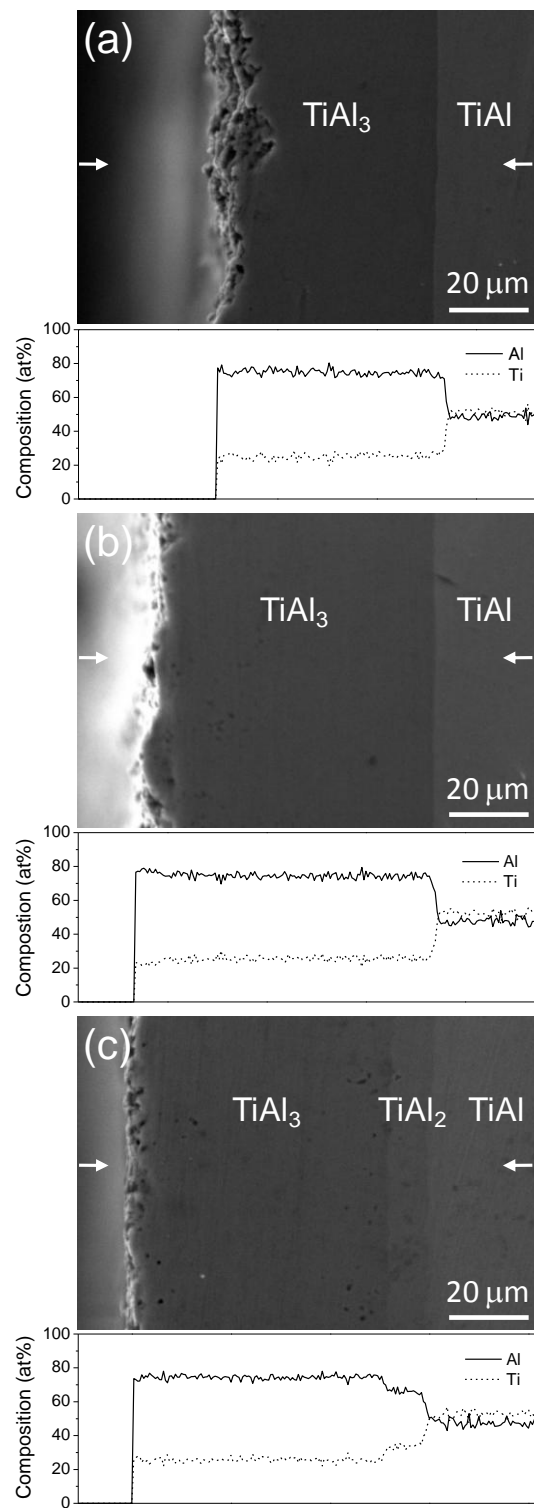


Fig. 7

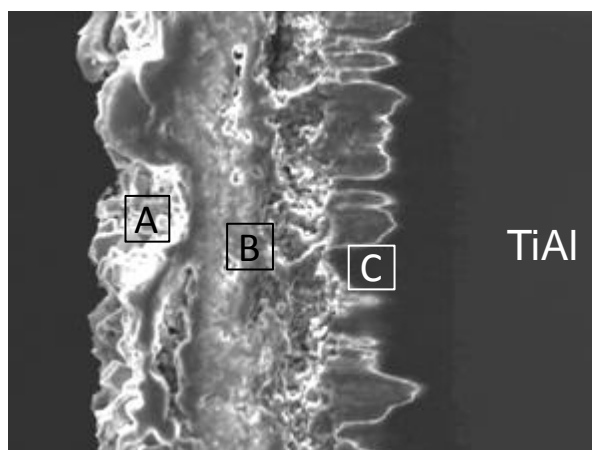


Fig. 8

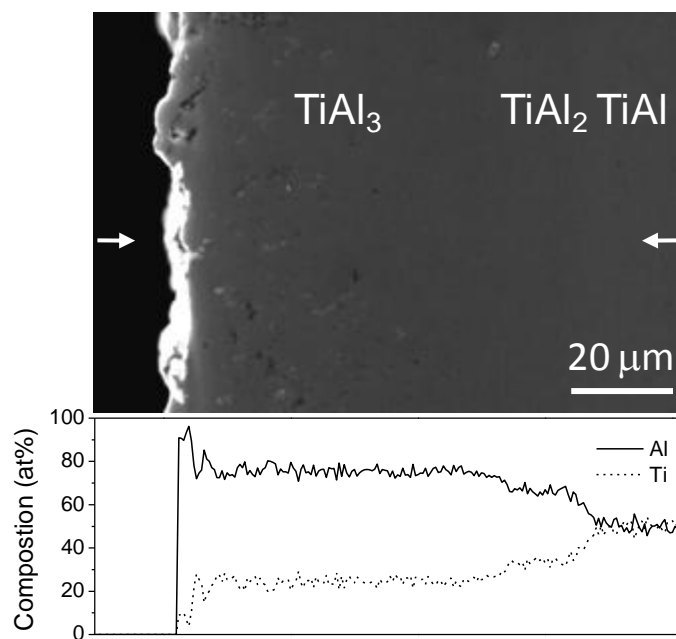


Fig. 9